

AMENDMENT TRANSMITTAL LETTER (Large Entity) Applicant(s): Tomoyuki Taguchi NOV 03 2003			Docket No. JP920000005US1(14606)	
Serial No. 09/917,959	Filing Date July 30, 2001	Examiner Emily Y. Chan	Group Art Unit 2829	

Invention: **INSPECTION METHOD FOR ARRAY SUBSTRATE AND INSPECTION DEVICE**
FOR THE SAME

TO THE COMMISSIONER FOR PATENTS:

Transmitted herewith is an amendment in the above-identified application.

The fee has been calculated and is transmitted as shown below.

CLAIMS AS AMENDED					
	CLAIMS REMAINING AFTER AMENDMENT	HIGHEST # PREV. PAID FOR	NUMBER EXTRA CLAIMS PRESENT	RATE	ADDITIONAL FEE
TOTAL CLAIMS	16 -	20 =	0 x	\$18.00	\$0.00
INDEP. CLAIMS	4 -	4 =	0 x	\$84.00	\$0.00
Multiple Dependent Claims (check if applicable) <input type="checkbox"/>					\$0.00
TOTAL ADDITIONAL FEE FOR THIS AMENDMENT					\$0.00

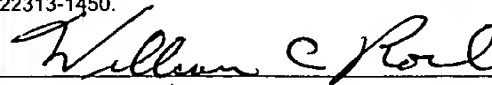
- ☒ No additional fee is required for amendment.
☐ Please charge Deposit Account No. _____ in the amount of _____
☐ A check in the amount of _____ to cover the filing fee is enclosed.
☒ The Director is hereby authorized to charge payment of the following fees associated with this communication or credit any overpayment to Deposit Account No. **50-0510/IBM**
- ☒ Any additional filing fees required under 37 C.F.R. 1.16.
☒ Any patent application processing fees under 37 CFR 1.17.


 Signature

Dated: October 30, 2003

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I certify that this document and fee is being deposited
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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s): Tomoyuki Taguchi

Examiner: Emily Y. Chan

Serial No.: 09/917,959

Art Unit: 2829

Filed: July 30, 2001

Docket: JP920000005US1 (14606)

For: INSPECTION METHOD FOR ARRAY
SUBSTRATE AND INSPECTION DEVICE
FOR THE SAME

Dated: October 30, 2003

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

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AMENDMENT UNDER 37 CFR 1.111

Sir:

Responsive to the Office Action of July 30, 2003, please amend this
patent application as follows:

Amendments to the Claims are reflected in the listing of claims which
begins on page 2 of this paper.

Remarks/Arguments begin on page 7 of this paper.

CERTIFICATE OF MAILING UNDER 37 C.F.R. §1.8(a)

I hereby certify that this correspondence is being deposited with the
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Dated: October 30, 2003


William C. Roch